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Electron Energy Dependent Charging Effects of Multilayered Dielectric Materials

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Electron Energy Dependent Charging Effects
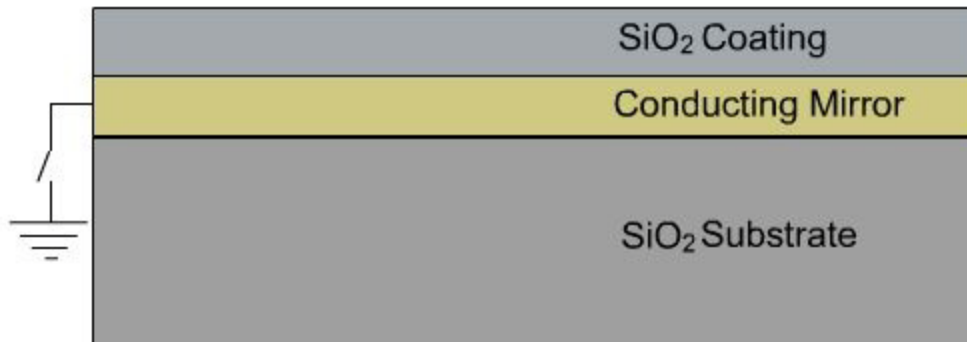# of Multilayered Dielectric Materials

Gregory Wilson, Amberly Evans and J.R. Dennison

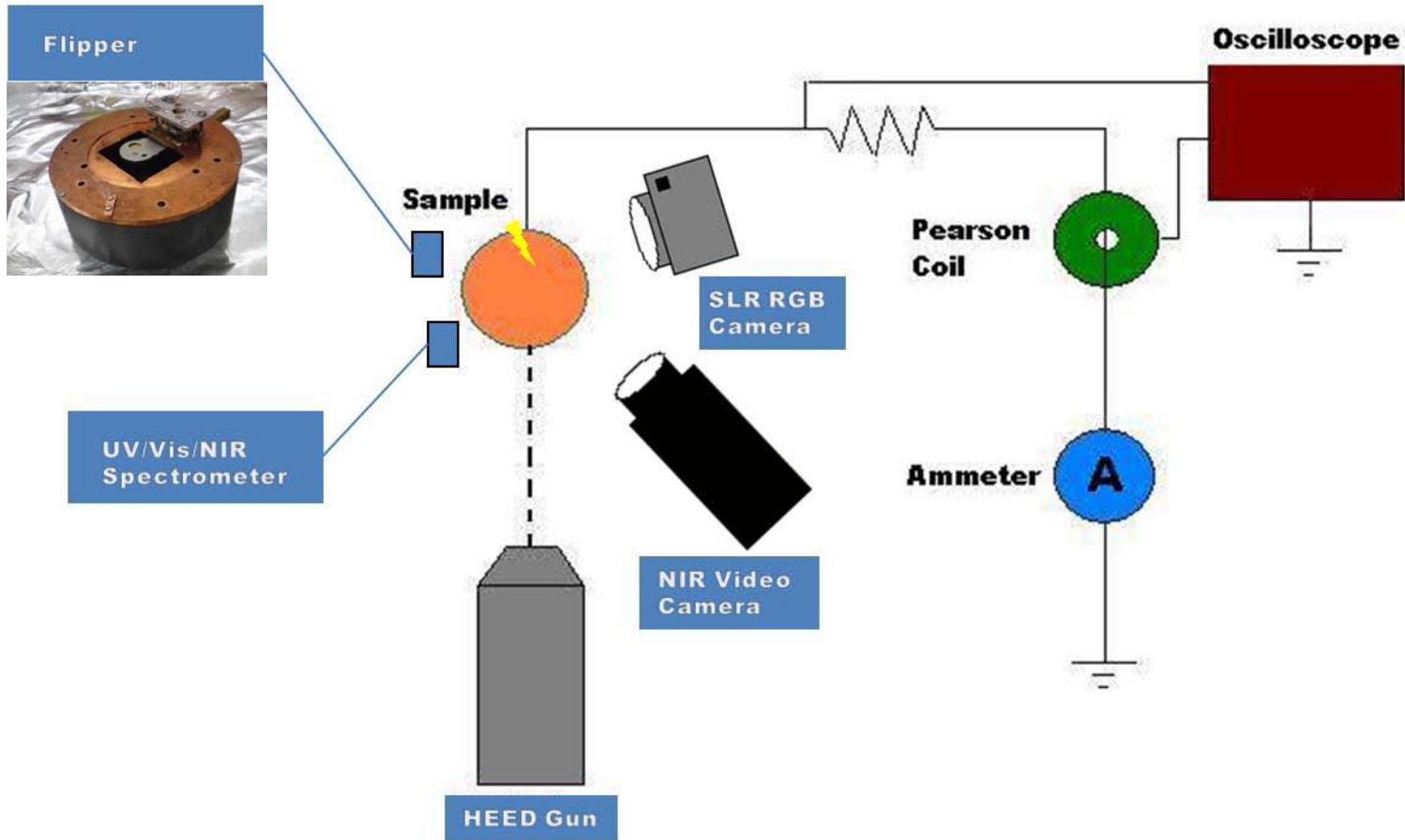Physics Department, Utah State University

Charging of Materials in the Space Environment

- Electrostatic discharge is the leading cause of spacecraft failure due to the space environment

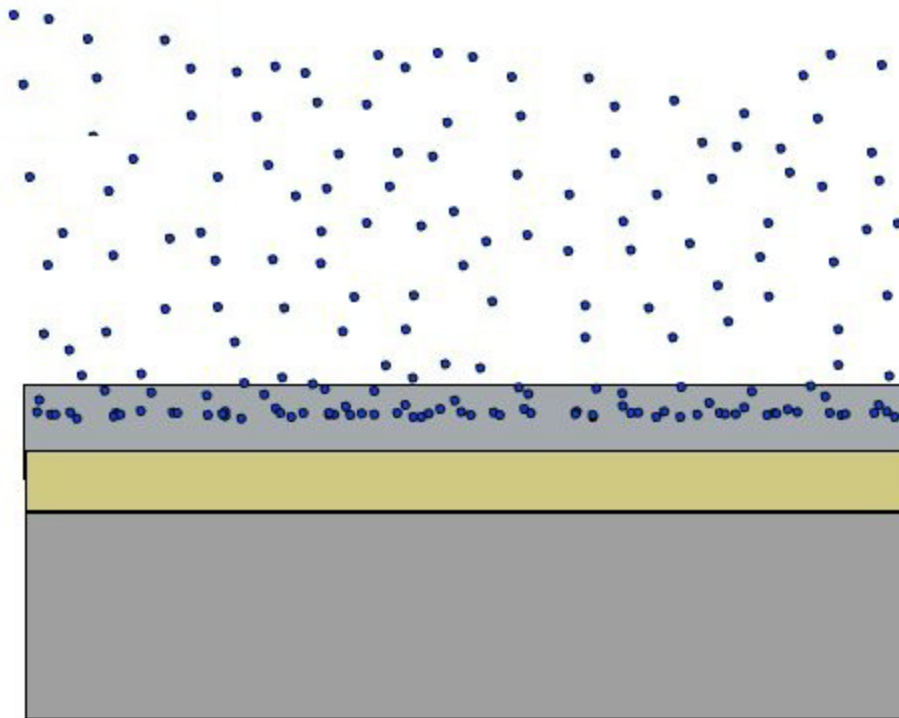# Experimental Design
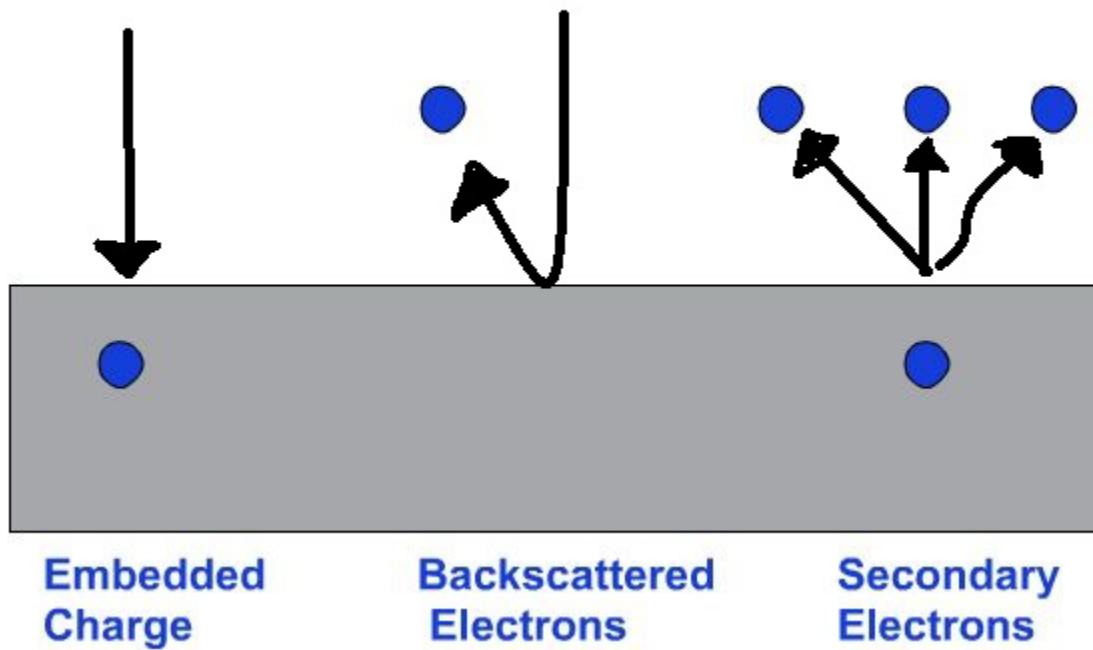
Experimental Setup

Internal Charge Evolution

- Range
- Electron Yield
- Conductivity

Range

- Depth electrons penetrate is energy dependent

Electron Yield

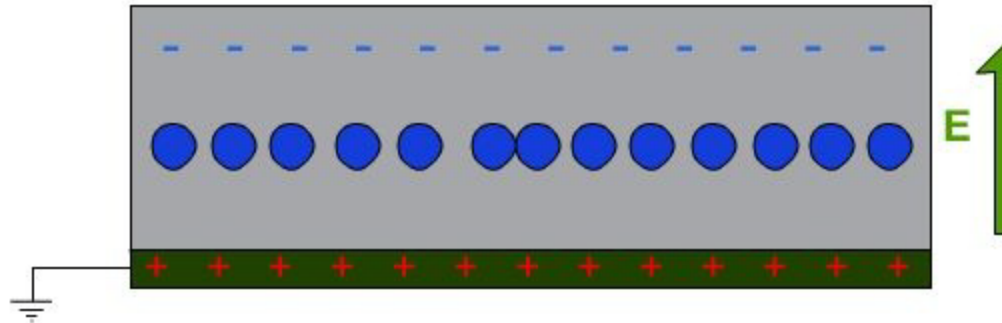**Embedded Charge** **Backscattered Electrons** **Secondary Electrons**
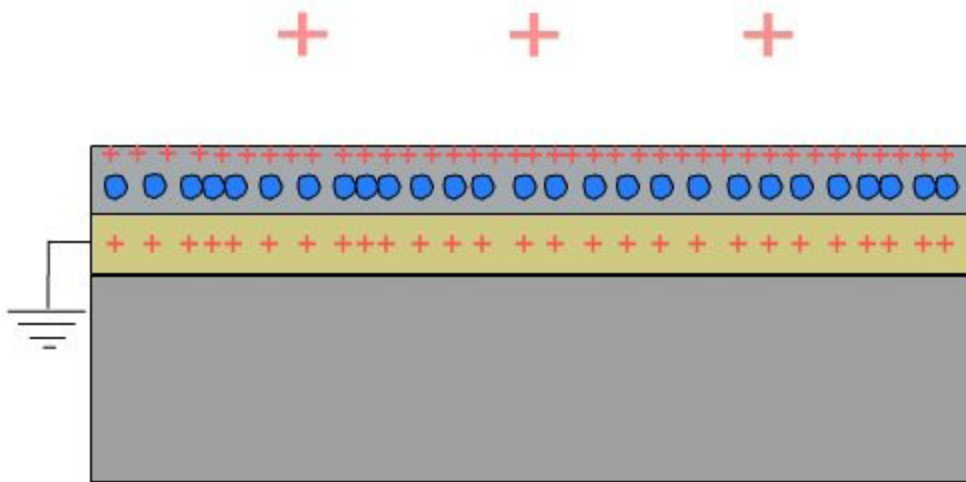
Conductivity

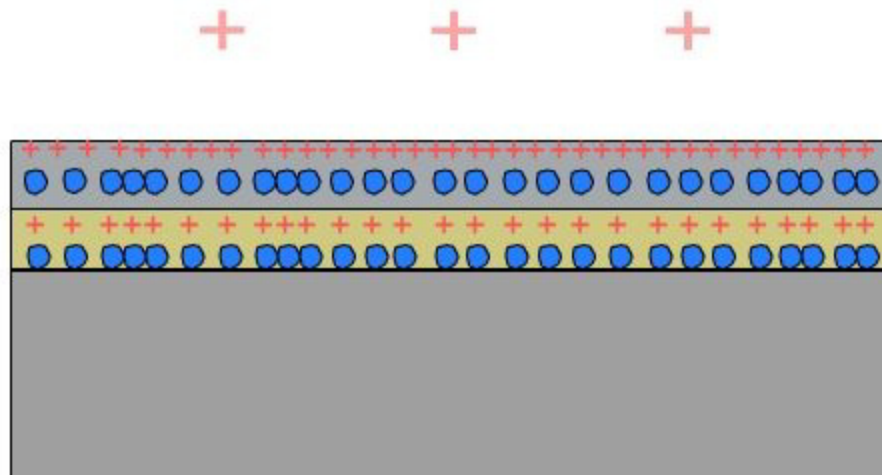- Conductivity determines deposited charge layer movement

Charging Scenarios

- Low Energy
  - Grounded
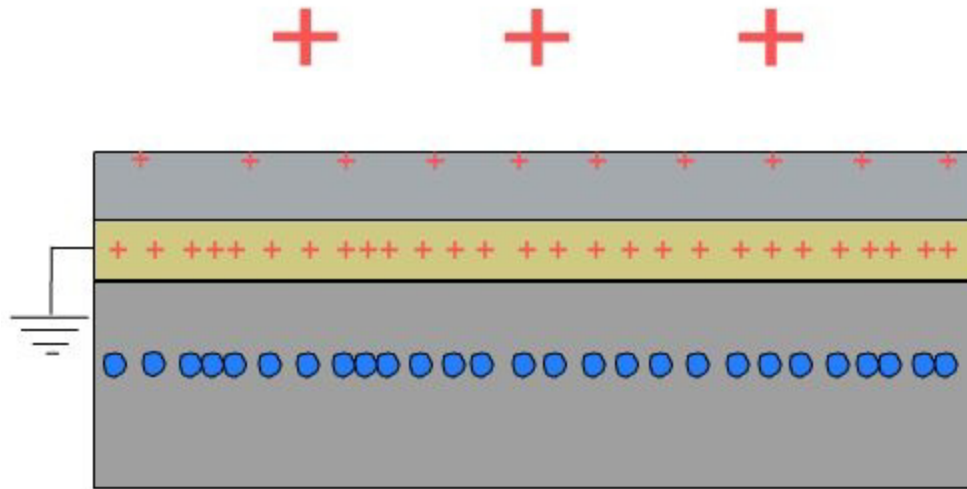 - Ungrounded
- High Energy
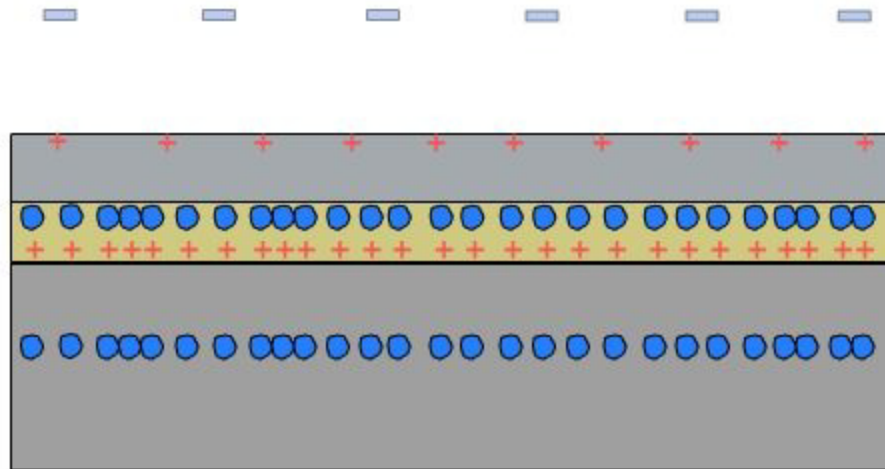 - Grounded
  - Ungrounded

Low Energy - Grounded

Low Energy - Ungrounded

High Energy - Grounded

High Energy - Ungrounded

Electrostatic Discharge

- High negative net potentials led to breakdown and arcing

In Conclusion We Observed:

- The charging of materials is dependent on the incident electron energy (through the range and electron yield) and conductivity of the material

$$V_s = \frac{\bar{J}_0[1 - Y(E_b)]}{\sigma_{DC}} R(E_b) \frac{[D - R(E_b)]}{D}$$

- Internal conductive layers, if grounded, can mask deep internal charging

- High negative net surface potentials resulted in electrostatic discharge

In Conclusion We Observed:

- These measurements and models allow the quantization and assesment of the charging of multilayered dielectric optical materials due to the space environment